More on Hypothesis Testing

Introduction

Consider the test of the hypotheses

$$H_0: \theta = \theta_0$$
 versus $H_1: \theta = \theta_1$

A 'best test' at significance level α would be the test with the greatest power. Our quest is to find such a test.

Deplose, we want to 1857 simple the simple null hypothesis

Ho: 0 = 0. A against the simple alternative hypothesis H: 0 = 0; (0, ±00).

In our 18sting problem. Then, the most appropriate CR come

corresponding to this 18st will be called the MPCR. Definition: A critical region wo is said to be an MPER of size d' for lesting to: 0200 vs. 41: 020, C+00) it

i) P(Wo | Ho) = x... 0, 10=0, +00 [some condition)

4 is P (Wolth) & PCW/HU. @, H 020, 700 t bower condition], helds, what ever be the other CR is gates lying @ may be.

2 Uniformly most powerful critical region [UMPCR]: @cooccorder. Sippose we want to lest the mills hypothesis Ho: 0 = 00 against the composité allémative hypothesis Hi: 0 700 inour lesting problem. Here, le most-appropriale cr will be colled the UMPCR. Definition: A CR co 18 said to be UMPCR, for lesting to be control. Ho: 0 = 000 of size is; if, i) P(wol Ho) # 22 [Size condition]

VD. Ho: 0 + 000 [Rower

Com salistyret & may be. cold ever the other cf ici very be. Smilarly de can define UMPCR for one sided allerrative hypothesis like, 17 Ho: 0 = 00. 2 24 Ho: 0 0 = 00.

Vs. Hi: 0700 vs. Hi: 0100.

3) Unbiased critical region: In most of the both sided lesting problems, It any UMPCR. In those silications, are have to introduce some JUMPER for MYB additional conditions or criterion over the size of the power conditions. This criteria is called the unbiasedness critéria. Definition: A CR' Wo of level of & powerB will be called an unbic

desirable situation.

(4) Uniformly & Most powerful Unbiased ex Critical Region [UMPUCA]. Definition: A CA Co of size à for l'esting Ho: 0200 against.

Definition: A CA Co of size à for l'esting Ho: 0200 against.

Hi 0 + 00 if it P(Cool Ho) 2 x ... @ [Size condition] of P(wolth) / P(woltho) [cumbiased ness orilaria] I wit P(Wolth) & P(W lt) E Power condition) whatever the other cp w salishing (1) + (1) may be.

Neyman – Pearson Lemma

Suppose that X_1, \ldots, X_n have joint pdf $f(x_1, \ldots, x_n | \theta_0)$ under H_0 and $f(x_1, \ldots, x_n | \theta_1)$ under H_1 . Define

$$\lambda(x_1, \dots, x_n; \theta_0, \theta_1) = \frac{f(x_1, \dots, x_n | \theta_0)}{f(x_1, \dots, x_n | \theta_1)}.$$
 (4.1)

Then $\lambda(x_1, \ldots, x_n; \theta_0, \theta_1)$ is the ratio of the likelihoods under H_0 and H_1 . Let the critical region $C^* \subseteq \Omega$ be

$$C^* = \{(x_1, \dots, x_n) : \lambda(x_1, \dots, x_n; \theta_0, \theta_1) \le k\}$$
(4.2)

where k is a constant chosen to make the test have significance level α , that is

$$P\{(X_1, \dots, X_n) \in C^* \mid H_0 \text{ true}\} = \alpha.$$

The test based on the critical region $C^* = \{(x_1, \ldots, x_n) : \lambda(x_1, \ldots, x_n; \theta_0, \theta_1) \leq k\}$ has the largest power (smallest type II error) of all tests with significance level α .

Thus, among all tests with a given probability of a type I error, the likelihood ratio test minimises the probability of a type II error.

Test of mean, when Variance is known

Suppose that X_1, \ldots, X_n are iid $N(\mu, \sigma^2)$ random quantities with σ^2 known. We shall apply the Neyman-Pearson lemma to construct the best test of the hypotheses

$$H_0: \mu = \mu_0$$
 versus $H_1: \mu = \mu_1$

where $\mu_1 > \mu_0$. From equation (4.1) we have that

$$\lambda(x_1, \dots, x_n; \mu_0, \mu_1) = \frac{f(x_1, \dots, x_n \mid \theta_0)}{f(x_1, \dots, x_n \mid \theta_1)}$$

$$= \frac{L(\mu_0)}{L(\mu_1)}$$

$$= \frac{\exp\left\{-\frac{1}{2\sigma^2} \sum_{i=1}^n (x_i - \mu_0)^2\right\}}{\exp\left\{-\frac{1}{2\sigma^2} \sum_{i=1}^n (x_i - \mu_1)^2\right\}}$$

$$= \exp\left\{\frac{1}{2\sigma^2} \left(\sum_{i=1}^n (x_i - \mu_1)^2 - \sum_{i=1}^n (x_i - \mu_0)^2\right)\right\}. \quad (4.3)$$

Now,

$$\sum_{i=1}^{n} (x_i - \mu_1)^2 - \sum_{i=1}^{n} (x_i - \mu_0)^2 = \sum_{i=1}^{n} (x_i^2 - 2\mu_1 x_i + \mu_1^2) - \sum_{i=1}^{n} (x_i^2 - 2\mu_0 x_i + \mu_0^2)$$

$$= -2\mu_1 n \overline{x} + n \mu_1^2 + 2\mu_0 n \overline{x} - n \mu_0^2$$

$$= n(\mu_1^2 - \mu_0^2) - 2n \overline{x} (\mu_1 - \mu_0). \tag{4.4}$$

Substituting equation (4.4) into (4.3) gives

$$\lambda(x_1, \dots, x_n; \mu_0, \mu_1) = \exp\left\{\frac{1}{2\sigma^2} \left(n(\mu_1^2 - \mu_0^2) - 2n\overline{x}(\mu_1 - \mu_0)\right)\right\}.$$

Using the Neyman-Pearson Lemma, see Lemma 1, the critical region of the most powerful test of significance level α for the test $H_0: \mu = \mu_0 \text{versus} H_1: \mu = \mu_1 \ (\mu_1 > \mu_0)$ is

$$C^* = \left\{ (x_1, \dots, x_n) : \exp\left\{ \frac{1}{2\sigma^2} \left(n(\mu_1^2 - \mu_0^2) - 2n\overline{x}(\mu_1 - \mu_0) \right) \right\} \le k \right\}$$

$$= \left\{ (x_1, \dots, x_n) : n(\mu_1^2 - \mu_0^2) - 2n\overline{x}(\mu_1 - \mu_0) \le 2\sigma^2 \log k \right\}$$

$$= \left\{ (x_1, \dots, x_n) : -2n\overline{x}(\mu_1 - \mu_0) \le 2\sigma^2 \log k + n(\mu_0^2 - \mu_1^2) \right\}$$

$$= \left\{ (x_1, \dots, x_n) : \overline{x} \ge \frac{-\sigma^2}{n(\mu_1 - \mu_0)} \log k + \frac{(\mu_0 + \mu_1)}{2} \right\}$$

$$= \left\{ (x_1, \dots, x_n) : \overline{x} \ge k^* \right\}. \tag{4.5}$$

$$k^* = \mu_0 + z_{(1-\alpha)} \frac{\sigma}{\sqrt{n}},$$

where $P(Z < z_{(1-\alpha)}) = 1-\alpha$. This is also written as $\Phi^{-1}(1-\alpha)$. $z_{(1-\alpha)}$ is the $(1-\alpha)$ -quantile of Z, the standard normal distribution.

A Practical Example of the Neyman-Pearson lemma

Suppose that the distribution of lifetimes of TV tubes can be adequately modelled by an exponential distribution with mean θ so

$$f(x \mid \theta) = \frac{1}{\theta} \exp\left(-\frac{x}{\theta}\right)$$

for $x \ge 0$ and 0 otherwise. Under usual production conditions, the mean lifetime is 2000 hours but if a fault occurs in the process, the mean lifetime drops to 1000 hours. A random sample of 20 tube lifetimes is to taken in order to test the hypotheses

$$H_0: \theta = 2000$$
 versus $H_1: \theta = 1000$.

Use the Neyman-Pearson lemma to find the most powerful test with significance level α .

Note that

$$L(\theta) = \prod_{i=1}^{20} f(x_i | \theta) = \frac{1}{\theta^{20}} \exp\left(-\frac{1}{\theta} \sum_{i=1}^{20} x_i\right)$$
$$= \frac{1}{\theta^{20}} \exp\left(-\frac{20\overline{x}}{\theta}\right).$$

Thus,

$$\lambda(x_1, \dots, x_{20}; \theta_0, \theta_1) = \frac{L(2000)}{L(1000)}$$

$$= \frac{\frac{1}{2000^{20}} \exp\left(-\frac{20\overline{x}}{2000}\right)}{\frac{1}{1000^{20}} \exp\left(-\frac{20\overline{x}}{1000}\right)}$$

$$= \left(\frac{1000}{2000}\right)^{20} \exp\left(-\frac{20\overline{x}}{2000} + \frac{20\overline{x}}{1000}\right)$$

$$= \frac{1}{2^{20}} \exp\left(\frac{\overline{x}}{100}\right).$$

Using the Neyman-Pearson lemma, the most powerful test of significance α has critical region

$$C^* = \left\{ (x_1, \dots, x_2) : \frac{1}{2^{20}} \exp\left(\frac{\overline{x}}{100}\right) \le k \right\}$$
$$= \left\{ (x_1, \dots, x_2) : \frac{\overline{x}}{100} \le \log 2^{20} k \right\}$$
$$= \left\{ (x_1, \dots, x_2) : \overline{x} \le k^* \right\}.$$

That is, a test of the form reject H_0 if $\overline{x} \leq k_1$. To find k^* , we need to know the sampling distribution of \overline{X} when X_1, \ldots, X_{20} are iid exponentials with mean $\theta = 2000$ as

$$P(\overline{X} \le k^* \mid \theta = 2000) = \alpha.$$

ho: x of f(x) = e-1, x se a discrete r.v. Suppose, Let, K21, for MPCR by MP lemma. Find the MPCR & show that it is unbiased.

Solution: Using MP lemma here the MPCR is W2 (2: fcm, M) 713. How, \$\frac{1}{2}(\alpha, \hi) \gamma 1 \Rightarrow \frac{1}{2}(\alpha, \hi) \gamma \frac{1}{2}(\alpha, \hi) \gamma \frac{1}{2} \rightarrow \frac{1}{2 $5 \ \mathbf{W} = \left\{ 2: \frac{n!}{n+1} \right\} = \left\{ n: \frac{n!}{2^n} \right\} \stackrel{2}{=} \left\{ 2: \frac{e}{2} \right\} \stackrel{2n}{=} \left\{ 2: \frac$ i, w= {09. is the # MPCR. Mow Phi(w) = Phi(x=0)= 1 21 Pho(w) = Phi(x 20) 2 1 Since P = 1 = Show, Ph, (w) > Pho(w) 22. So, Pover & Size. is The lest 18 unbiased. [Presed]

Power function. Definition: Let, 8 be a lest of the nell hypothegis to. Then, the power function of the lest 'V', denoted by B(0)' is defined to be the probability that Ho is rejected when the distribution from which the sample was obtained was parameterized by O. As such, B(O) is given by B(0) = & Probability of lipe-I error associated with o, if one of In other words, BCO) = PH, Cho) is the probability of rejecting a love mult hypothesis, re the probability of accepting a true null hypothesis, of the probability of accepting a true null hypothesis, of the probability of accepting a true null hypothesis, the right decision.

Use of bower tunction: The whole nature of the lest can be judged by bolking at the power function. The power function plays the same role in hypothesis lésling that meansquare error plays in estimation. It is usually the standard in as assessing the goodness of a lest or in comparing two competing lests. An ideal power function is a function that assumes the value of for those of corresponding to the Ho of is anily for those of corresponding to the hopothesis H. As such power function is useful in lelling how good a particular lest is. Enample: Let, XI UN NCO, 25) Viricim. To lest pho: 0417. Let; it is decided 6 reject the lest iff 7717+5 5 B(0)= PO[x) 14+5]=1-\$ (17+5/10-0) Here, it cor 20, the lest is almost certain not to reject no . es it should. If 0 <16 the lest is almost certain not to reject to 918 17LOCIS, CAO, NO 13 folse) the UST has less than 1/2 a chance of rejecting to. flower Curve forth non-25